

CY74FCT823T

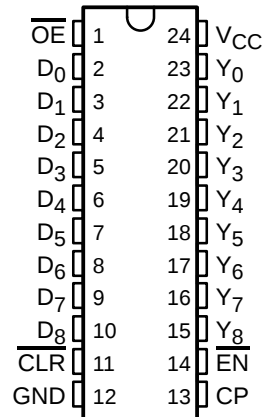
9-BIT BUS-INTERFACE REGISTER

WITH 3-STATE OUTPUTS

SCCS069A – OCTOBER 2001 – REVISED NOVEMBER 2001

- Function, Pinout, and Drive Compatible With FCT, F Logic, and AM29823
- Reduced V_{OH} (Typically = 3.3 V) Version of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- I_{off} Supports Partial-Power-Down Mode Operation
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- 64-mA Output Sink Current
32-mA Output Source Current
- High-Speed Parallel Register With Positive-Edge-Triggered D-Type Flip-Flops
- Buffered Common Clock-Enable ($\overline{EN}$) and Asynchronous-Clear ($\overline{CLR}$) Inputs
- 3-State Outputs

P, Q, OR SO PACKAGE
(TOP VIEW)



description

This bus-interface register is designed to eliminate the extra packages required to buffer existing registers and provide extra data width for wider address/data paths or buses carrying parity. The CY74FCT823T is a 9-bit-wide buffered register with clock-enable ($\overline{EN}$) and clear ($\overline{CLR}$) inputs that are ideal for parity bus interfacing in high-performance microprogrammed systems. It is ideal for use as an output port requiring high I_{OL}/I_{OH} .

This device is designed for high-capacitance load drive capability, while providing low-capacitance bus loading at both inputs and outputs. Outputs are designed for low-capacitance bus loading in the high-impedance state.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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ORDERING INFORMATION

T _A	PACKAGE†		SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	QSOP – Q	Tape and reel	6	CY74FCT823CTQCT	FCT823C
	SOIC – SO	Tube	6	CY74FCT823CTSOC	FCT823C
		Tape and reel	6	CY74FCT823CTSOCT	
	DIP – P	Tube	7.5	CY74FCT823BTPC	CY74FCT823BTPC
	DIP – P	Tube	10	CY74FCT823ATPC	CY74FCT823ATPC
	QSOP – Q	Tape and reel	10	CY74FCT823ATQCT	FCT823A
	SOIC – SO	Tube	10	CY74FCT823ATSOC	FCT823A
		Tape and reel	10	CY74FCT823ATSOCT	

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

PIN DESCRIPTION

NAME	I/O	DESCRIPTION
D	I	D flip-flop data inputs
$\overline{\text{CLR}}$	I	When $\overline{\text{CLR}}$ is low and $\overline{\text{OE}}$ is low, Q outputs are low. When $\overline{\text{CLR}}$ is high, data can be entered into the register.
CP	O	Clock pulse for the register. Enters data into the register on the low-to-high clock transition.
Y	O	Register 3-state outputs
$\overline{\text{EN}}$	I	Clock enable. When $\overline{\text{EN}}$ is low, data on the D input is transferred to the Q output on the low-to-high clock transition. When $\overline{\text{EN}}$ is high, the Q outputs do not change state, regardless of the data or clock input transitions.
$\overline{\text{OE}}$	I	Output control. When $\overline{\text{OE}}$ is high, the Y outputs are in the high-impedance state. When $\overline{\text{OE}}$ is low, true register data is present at the Y outputs.

FUNCTION TABLE

INPUTS					INTERNAL OUTPUTS		FUNCTION
$\overline{\text{OE}}$	$\overline{\text{CLR}}$	$\overline{\text{EN}}$	D	CP	Q	Y	
H	H	L	L	↑	L	Z	Z
H	H	L	H	↑	H	Z	
H	L	X	X	X	L	Z	Clear
L	L	X	X	X	L	L	
H	H	H	X	X	NC	Z	Hold
L	H	H	X	X	NC	NC	
H	H	L	L	↑	L	Z	Load
H	H	L	H	↑	H	Z	
L	H	L	L	↑	L	L	
L	H	L	H	↑	H	H	

H = High logic level, L = Low logic level, X = Don't care, NC = No change, ↑ = Low-to-high transition, Z = High-impedance state



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The logic diagram illustrates a 24-channel 1-bit parallel adder. The ALU (74181) is configured with the following inputs and outputs:

- Inputs:** $\overline{OE}$ (1), $\overline{CLR}$ (11), $\overline{EN}$ (14), CP (13), and D_0 (2).
- Outputs:** CL , CP , Q , and D_0 .
- Logic:** The $\overline{EN}$ input is connected to an OR gate and an AND gate. The CP input is connected to the same AND gate. The output of the OR gate is connected to the $\overline{CLR}$ input. The output of the AND gate is connected to the CL input. The Q output is inverted to produce Y_0 (23).
- Connections:** The CL , CP , and Q outputs are connected to a 24-channel bus, indicated by a bracket labeled "To Eight Other Channels".

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS		MIN	TYP [†]	MAX	UNIT
V _{IK}	V _{CC} = 4.75 V,	I _{IN} = −18 mA		−0.7	−1.2	V
V _{OH}	V _{CC} = 4.75 V	I _{OH} = −32 mA	2		V	
		I _{OH} = −15 mA	2.4	3.3		
V _{OL}	V _{CC} = 4.75 V,	I _{OL} = 64 mA		0.3	0.55	V
V _{hys}	All inputs			0.2		V
I _I	V _{CC} = 5.25 V,	V _{IN} = V _{CC}			5	μA
I _{IH}	V _{CC} = 5.25 V,	V _{IN} = 2.7 V			±1	μA
I _{IL}	V _{CC} = 5.25 V,	V _{IN} = 0.5 V			±1	μA
I _{OZH}	V _{CC} = 5.25 V,	V _{OUT} = 2.7 V			10	μA
I _{OZL}	V _{CC} = 5.25 V,	V _{OUT} = 0.5 V			−10	μA
I _{OS} [‡]	V _{CC} = 5.25 V,	V _{OUT} = 0 V	−60	−120	−225	mA
I _{off}	V _{CC} = 0 V,	V _{OUT} = 4.5 V			±1	μA
I _{CC}	V _{CC} = 5.25 V,	V _{IN} ≤ 0.2 V, V _{IN} ≥ V _{CC} − 0.2 V		0.1	0.2	mA
ΔI _{CC}	V _{CC} = 5.25 V, V _{IN} = 3.4 V [§] , f ₁ = 0, Outputs open			0.5	2	mA
I _{CCD} [¶]	V _{CC} = 5.25 V, One bit switching at 50% duty cycle, Outputs open, OE = EN = GND, V _{IN} ≤ 0.2 V or V _{IN} ≥ V _{CC} − 0.2 V			0.06	0.12	mA/MHz
I _C [#]	V _{CC} = 5.25 V, Outputs open, OE = EN = GND	One bit switching at f ₁ = 5 MHz at 50% duty cycle	V _{IN} ≤ 0.2 V or V _{IN} ≥ V _{CC} − 0.2 V	0.7	1.4	mA
			V _{IN} = 3.4 V or GND	1.2	3.4	
		Eight bits switching at f ₁ = 2.5 MHz at 50% duty cycle	V _{IN} ≤ 0.2 V or V _{IN} ≥ V _{CC} − 0.2 V	1.6	3.2	
			V _{IN} = 3.4 V or GND	3.9	12.2	
C _i				5	10	pF
C _o				9	12	pF

[†] Typical values are at $V_{CC} = 5\text{ V}$, $T_A = 25^\circ\text{C}$.

[‡] Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

[§] Per TTL-driven input ($V_{IN} = 3.4\text{ V}$); all other inputs at V_{CC} or GND

^{\P} This parameter is derived for use in total power-supply calculations.

^{\#} $I_C = I_{CC} + \Delta I_{CC} \times D_H \times N_T + I_{CCD} (f_0/2 + f_1 \times N_1)$

Where:

I_C = Total supply current

I_{CC} = Power-supply current with CMOS input levels

ΔI_{CC} = Power-supply current for a TTL high input ($V_{IN} = 3.4\text{ V}$)

D_H = Duty cycle for TTL inputs high

N_T = Number of TTL inputs at D_H

I_{CCD} = Dynamic current caused by an input transition pair (HLH or LHL)

f_0 = Clock frequency for registered devices, otherwise zero

f_1 = Input signal frequency

N_1 = Number of inputs changing at f_1

All currents are in milliamperes and all frequencies are in megahertz.

|| Values for these conditions are examples of the I_{CC} formula.



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timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER			TEST LOAD	CY74FCT823AT		CY74FCT823BT		CY74FCT823CT		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t_w	Pulse duration	CP	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	7		6		6		ns
		$\overline{\text{CLR}}$ low		6		6		6		
t_{su}	Setup time, before CP $\uparrow$	Data	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	4		3		3		ns
		$\overline{\text{EN}}$		4		3		3		
t_h	Hold time, after CP $\uparrow$	Data	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	2		1.5		1.5		ns
		$\overline{\text{EN}}$		2		0		0		
t_{rec}	Recovery time	$\overline{\text{CLR}}$ before CP $\uparrow$	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	6		6		6		ns

switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST LOAD	CY74FCT823AT		CY74FCT823BT		CY74FCT823CT		UNIT
				MIN	MAX	MIN	MAX	MIN	MAX	
t_{PLH}	CP	Y	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	10		7.5		6		ns
t_{PHL}				10		7.5		6		
t_{PLH}	CP	Y	$C_L = 300 \text{ pF}$, $R_L = 500 \Omega$	20		15		12.5		ns
t_{PHL}				20		15		12.5		
t_{PLH}	$\overline{\text{CLR}}$	Y	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	14		9		8		ns
t_{PZH}	$\overline{\text{OE}}$	Y	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	12		8		7		ns
t_{PZL}				12		8		7		
t_{PZH}	$\overline{\text{OE}}$	Y	$C_L = 300 \text{ pF}$, $R_L = 500 \Omega$	23		15		12.5		ns
t_{PZL}				23		15		12.5		
t_{PHZ}	$\overline{\text{OE}}$	Y	$C_L = 5 \text{ pF}$, $R_L = 500 \Omega$	7		6.5		6		ns
t_{PLZ}				7		6.5		6		
t_{PHZ}	$\overline{\text{OE}}$	Y	$C_L = 50 \text{ pF}$, $R_L = 500 \Omega$	8		7.5		6.5		ns
t_{PLZ}				8		7.5		6.5		

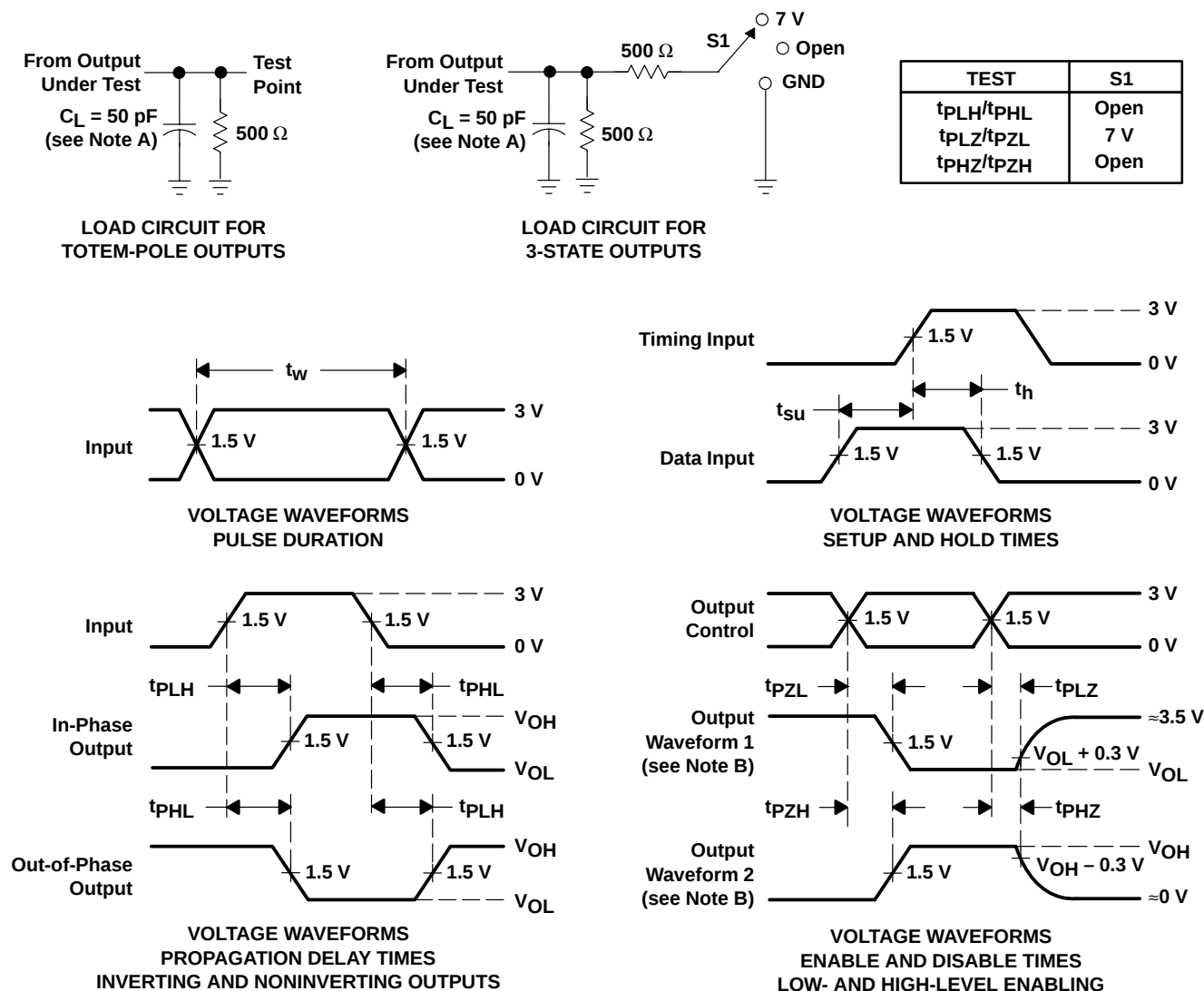
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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. C_L includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CY74FCT823ATQCT	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT823A
CY74FCT823ATQCT.B	Active	Production	SSOP (DBQ) 24	2500 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT823A
CY74FCT823ATSOC	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT823A
CY74FCT823ATSOC.B	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT823A
CY74FCT823CTSOC	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT823C
CY74FCT823CTSOC.B	Active	Production	SOIC (DW) 24	25 TUBE	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT823C

⁽¹⁾ **Status:** For more details on status, see our [product life cycle](#).

⁽²⁾ **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

⁽⁴⁾ **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

⁽⁵⁾ **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT823ATQCT	SSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT823ATQCT	SSOP	DBQ	24	2500	353.0	353.0	32.0

TUBE

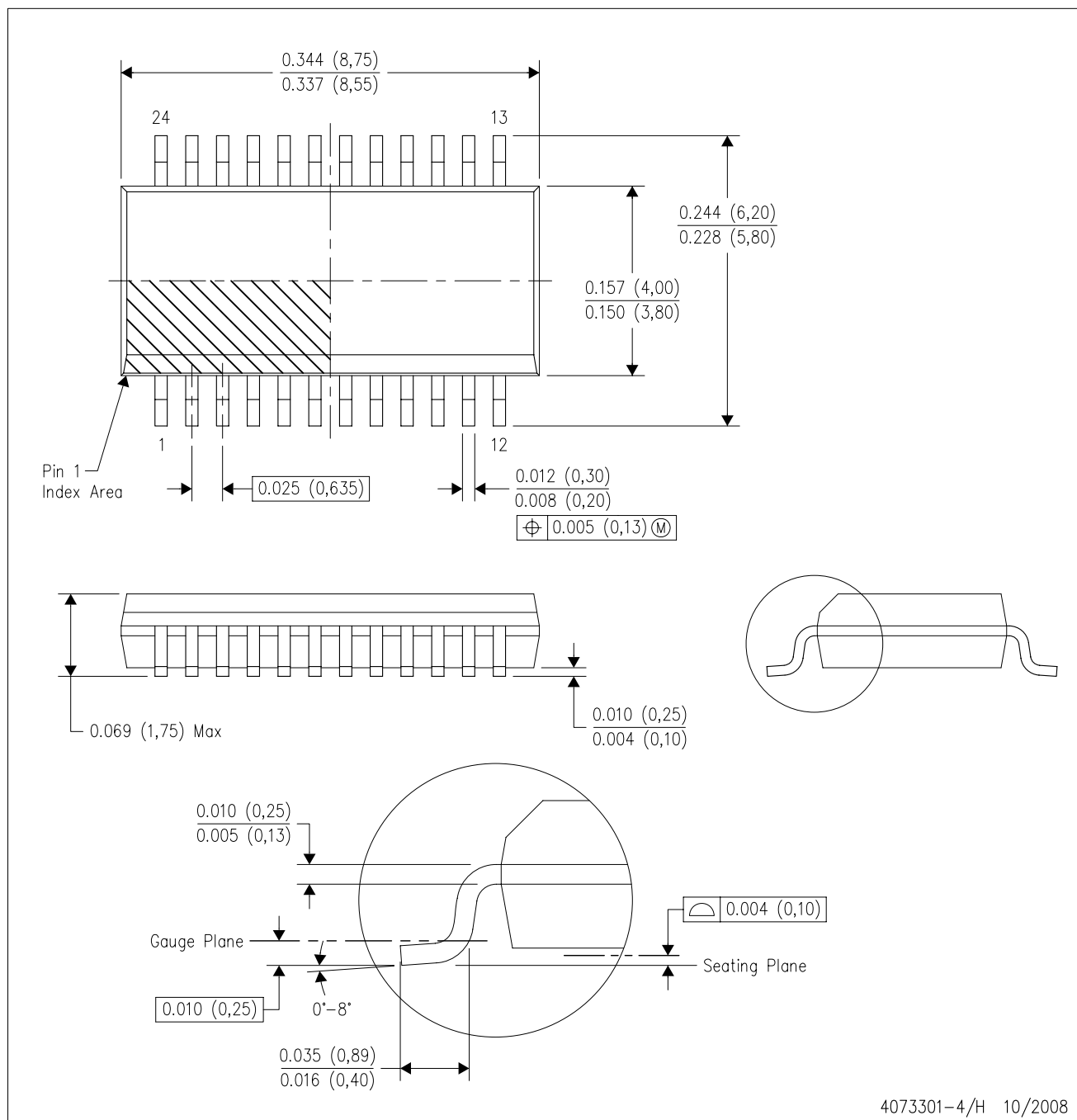


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CY74FCT823ATSOC	DW	SOIC	24	25	506.98	12.7	4826	6.6
CY74FCT823ATSOC.B	DW	SOIC	24	25	506.98	12.7	4826	6.6
CY74FCT823CTSOC	DW	SOIC	24	25	506.98	12.7	4826	6.6
CY74FCT823CTSOC.B	DW	SOIC	24	25	506.98	12.7	4826	6.6

DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
 - D. Falls within JEDEC MO-137 variation AE.

DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
 - D. Falls within JEDEC MS-013 variation AD.

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